Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/616,998	KIM, HAE-KYOUNG		
Examiner	Art Unit		

1745

Karie O'Neill

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consulted Dah-wei Yuan Re: arguments	6/12/2007	KAO.	
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